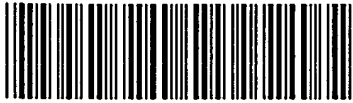


Search Notes

Application/Control No.

10/760,176

Examiner

Steven Loke

Applicant(s)/Patent under
Reexamination

WACHI, REIKO

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
349	106, 113, 114	8/4/2005	SL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB) - See Search History Printout	8/4/2005	sl